



Yixin

Advanced Power MOSFET

SSP7N60A

**FEATURES**

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 25  $\mu$ A (Max.) @  $V_{DS} = 600V$
- Lower  $R_{DS(ON)}$  : 0.977  $\Omega$  (Typ.)

$BV_{DSS} = 600 V$   
 $R_{DS(on)} = 1.2 \Omega$   
 $I_D = 7 A$



1.Gate 2. Drain 3. Source

**Absolute Maximum Ratings**

Symbol	Characteristic	Value	Units
$V_{DSS}$	Drain-to-Source Voltage	600	V
$I_D$	Continuous Drain Current ( $T_C=25^\circ C$ )	7	A
	Continuous Drain Current ( $T_C=100^\circ C$ )	4.4	
$I_{DM}$	Drain Current-Pulsed ①	28	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy ②	535	mJ
$I_{AR}$	Avalanche Current ①	7	A
$E_{AR}$	Repetitive Avalanche Energy ①	14.7	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	3.0	V/ns
$P_D$	Total Power Dissipation ( $T_C=25^\circ C$ )	147	W
	Linear Derating Factor	1.18	$\cdot {}^\circ C$
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	- 55 to +150	${}^\circ C$
	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

**Thermal Resistance**

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	0.85	${}^\circ C/W$
$R_{\theta CS}$	Case-to-Sink	0.5	--	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

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## Electrical Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	600	—	—	V	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	—	0.65	—	$^\circ\text{C}$	$I_D=250\mu\text{A}$ See Fig 7
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}}=5\text{V}, I_D=250\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage, Forward	—	—	100	nA	$V_{\text{GS}}=30\text{V}$
	Gate-Source Leakage, Reverse	—	—	-100		$V_{\text{GS}}=-30\text{V}$
$I_{\text{DS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{\text{DS}}=600\text{V}$
		—	—	250		$V_{\text{DS}}=480\text{V}, T_C=125^\circ\text{C}$
$R_{\text{DS(on)}}$	Static Drain-Source On-State Resistance	—	—	1.2	$\Omega$	$V_{\text{GS}}=10\text{V}, I_D=3.5\text{A}$ ④
$g_{\text{fs}}$	Forward Transconductance	—	5.73	—	$\text{mS}$	$V_{\text{DS}}=50\text{V}, I_D=3.5\text{A}$ ④
$C_{\text{iss}}$	Input Capacitance	—	1150	1500	pF	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
$C_{\text{oss}}$	Output Capacitance	—	130	150		
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	53	62		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	18	45	ns	$V_{\text{DD}}=300\text{V}, I_D=7\text{A}, R_G=9.1\Omega$ See Fig 13 ④ ⑤
$t_r$	Rise Time	—	19	50		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	72	155		
$t_f$	Fall Time	—	28	65		
$Q_g$	Total Gate Charge	—	49	65	nC	$V_{\text{DS}}=480\text{V}, V_{\text{GS}}=10\text{V}, I_D=7\text{A}$ See Fig 6 & Fig 12 ④ ⑤
$Q_{\text{gs}}$	Gate-Source Charge	—	8.4	—		
$Q_{\text{gd}}$	Gate-Drain("Miller") Charge	—	22.1	—		

## Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$I_s$	Continuous Source Current	—	—	7	A	Integral reverse pn-diode in the MOSFET
$I_{\text{SM}}$	Pulsed-Source Current ①	—	—	28	A	
$V_{\text{SD}}$	Diode Forward Voltage ④	—	—	1.4	V	$T_J=25^\circ\text{C}, I_s=7\text{A}, V_{\text{GS}}=0\text{V}$
$t_{\text{rr}}$	Reverse Recovery Time	—	415	—	ns	$T_J=25^\circ\text{C}, I_F=7\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	3.8	—	$\mu\text{C}$	$dI_F/dt=100\text{A}/\mu\text{s}$ ④

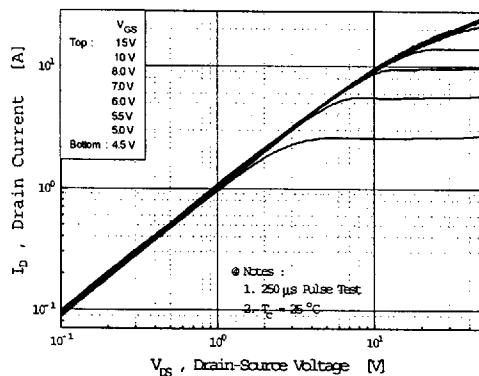
### Notes :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ②  $L=20\text{mH}, I_{AS}=7\text{A}, V_{DD}=50\text{V}, R_G=27\Omega$ , Starting  $T_J=25^\circ\text{C}$
- ③  $I_{SD}\leq 7\text{A}, di/dt\leq 120\text{A}/\mu\text{s}, V_{DD}\leq \text{BV}_{\text{DSS}}$ , Starting  $T_J=25^\circ\text{C}$
- ④ Pulse Test : Pulse Width =  $250\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature

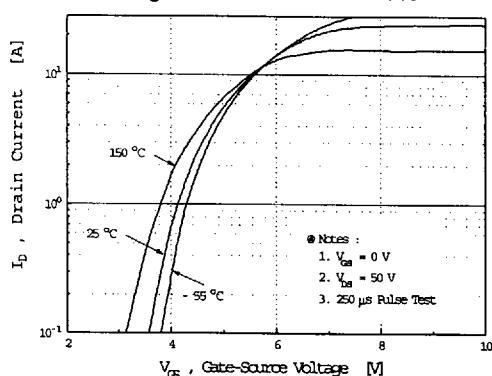
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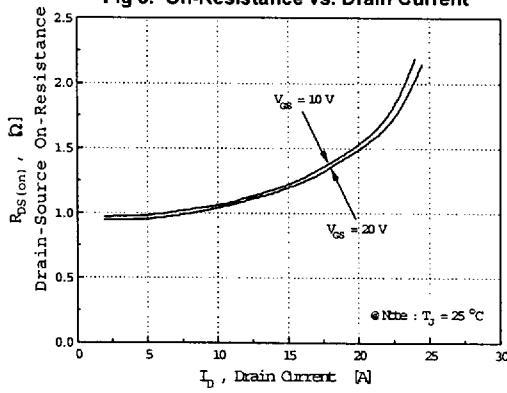
**Fig 1. Output Characteristics**



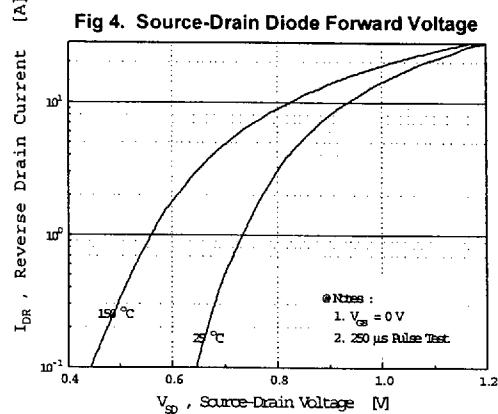
**Fig 2. Transfer Characteristics**



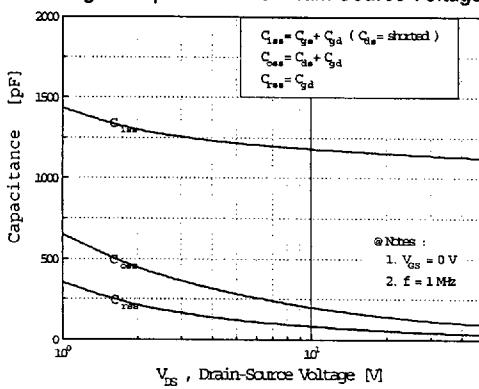
**Fig 3. On-Resistance vs. Drain Current**



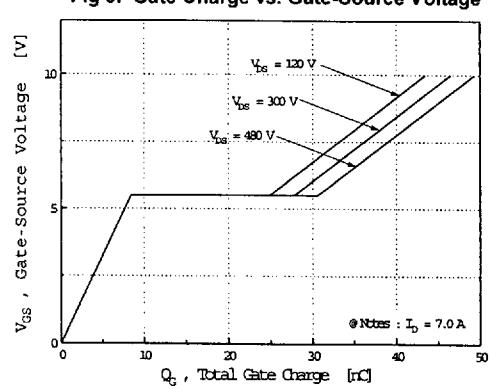
**Fig 4. Source-Drain Diode Forward Voltage**



**Fig 5. Capacitance vs. Drain-Source Voltage**

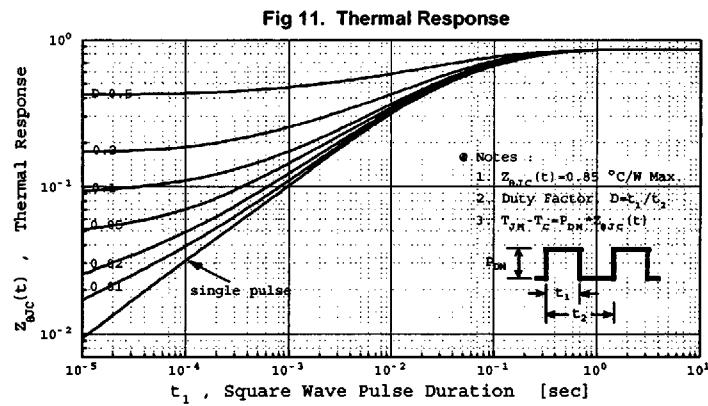
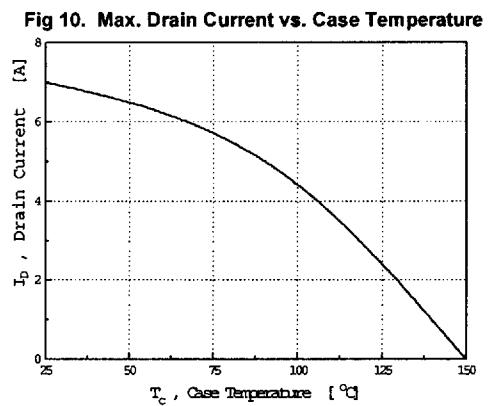
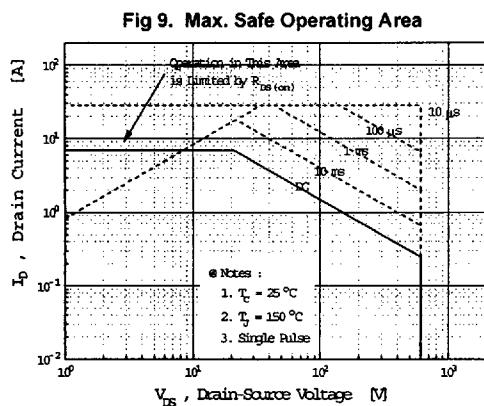
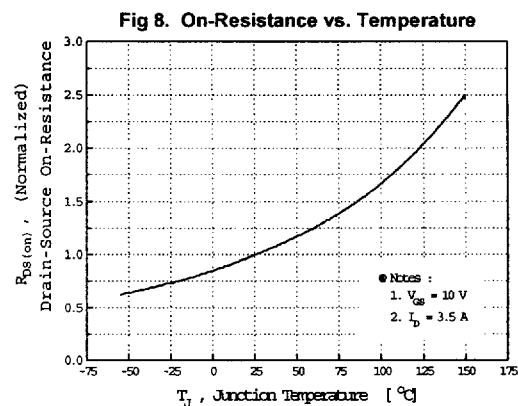
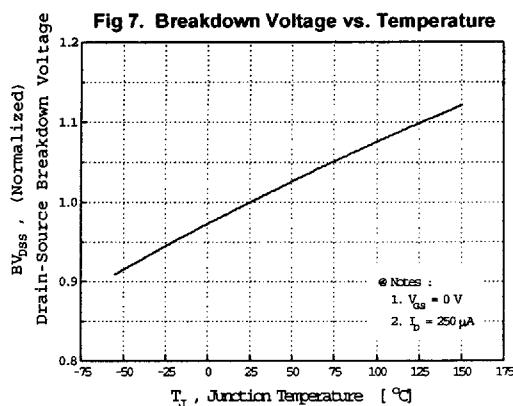


**Fig 6. Gate Charge vs. Gate-Source Voltage**



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Fig 12. Gate Charge Test Circuit & Waveform

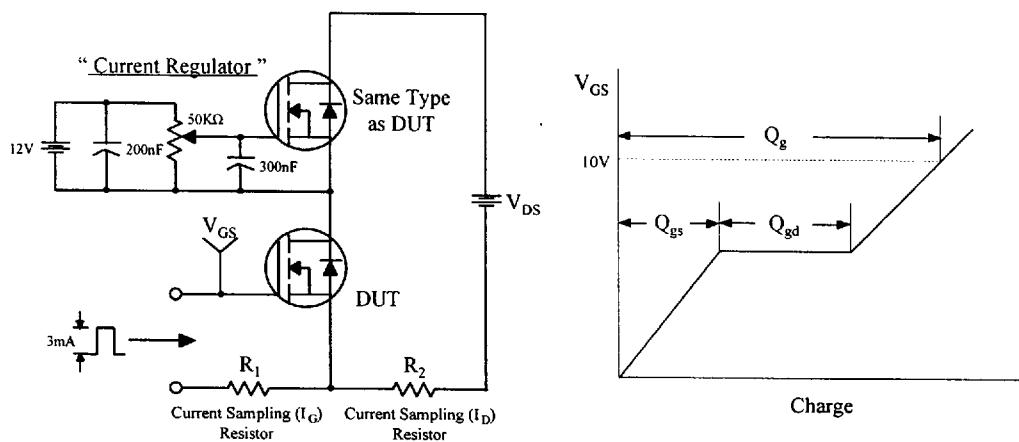


Fig 13. Resistive Switching Test Circuit & Waveforms

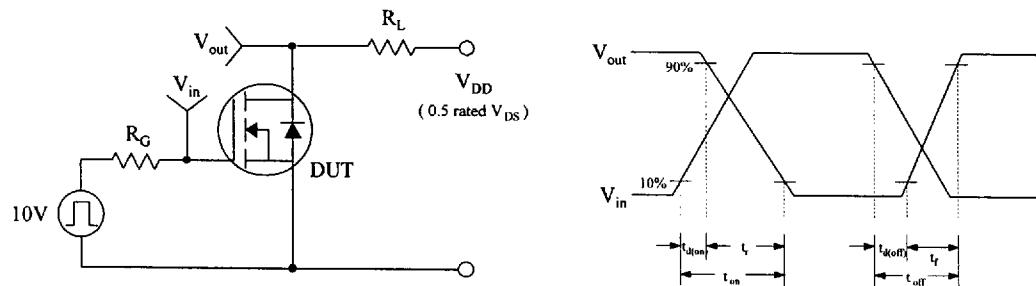


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

